

## Description

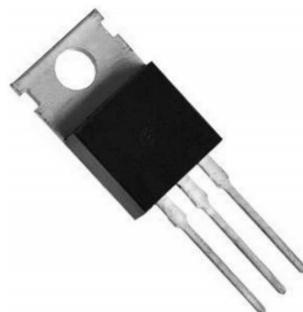
The IRF9530-ML uses advanced trench technology and design to provide excellent  $R_{DS(ON)}$  with low gate charge. It can be used in a wide variety of applications. It is ESD protected.

## General Features

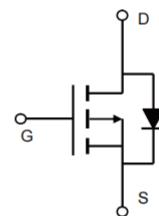
- $V_{DS} = -100V, I_D = -13A$
- $R_{DS(ON)} < 200m\Omega @ V_{GS} = -10V$  (Typ:  $170m\Omega$ )
- Super high dense cell design
- Advanced trench process technology
- Reliable and rugged
- High density cell design for ultra low on-resistance

## Application

- Power switch
- DC/DC converters



TO-220



Schematic

## Absolute Maximum Ratings ( $T_c=25^\circ C$ unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	$V_{DS}$	-100	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	V
Drain Current-Continuous	$I_D$	-13	A
Drain Current-Continuous( $T_c=100^\circ C$ )	$I_D (100^\circ C)$	-9.2	A
Pulsed Drain Current	$I_{DM}$	-52	A
Maximum Power Dissipation	$P_D$	40	W
Derating factor		0.27	W/ $^\circ C$
Single pulse avalanche energy <sup>(Note 5)</sup>	$E_{AS}$	110	mJ
Operating Junction and Storage Temperature Range	$T_J, T_{STG}$	-55 To 175	$^\circ C$

**Thermal Characteristic**

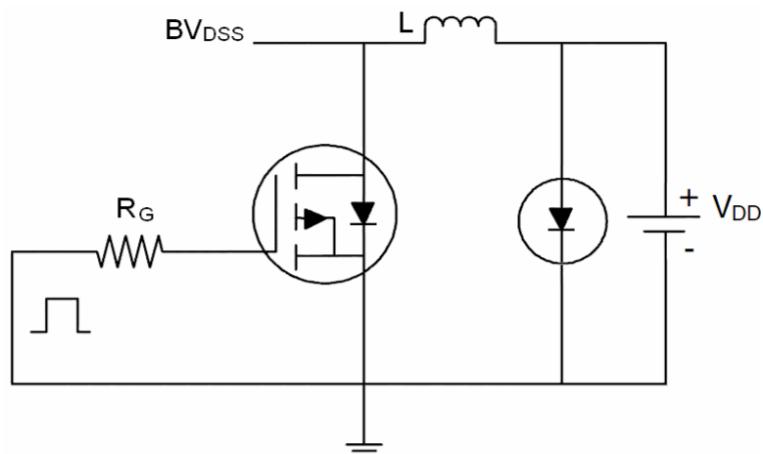
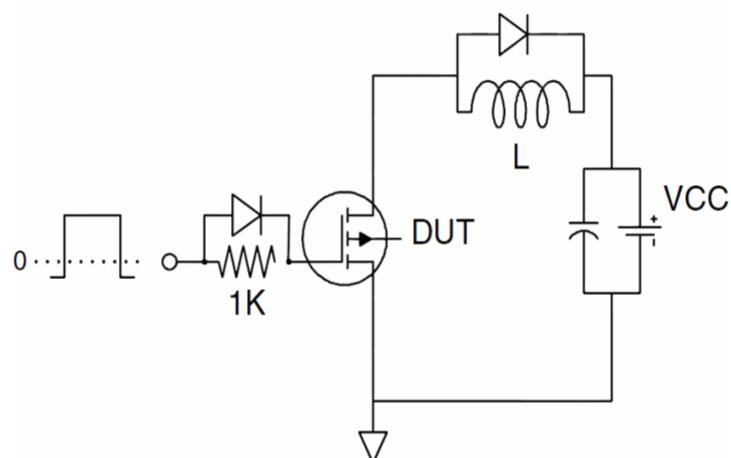
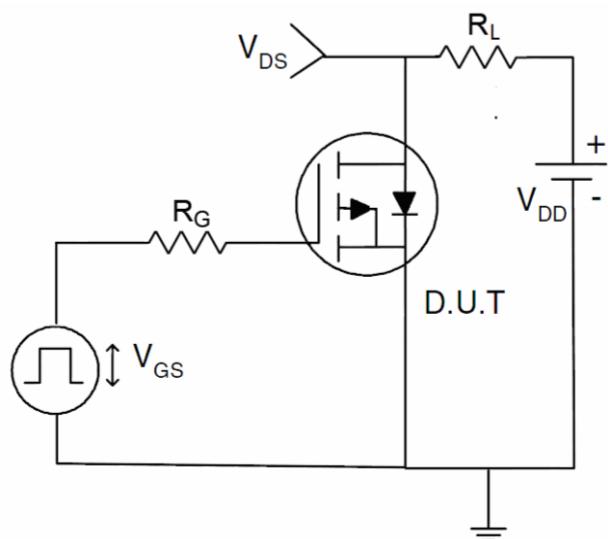
Thermal Resistance, Junction-to-Case <sup>(Note 2)</sup>	$R_{\theta JC}$	3.75	$^{\circ}\text{C}/\text{W}$
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**Electrical Characteristics ( $T_c=25^{\circ}\text{C}$  unless otherwise noted)**

Parameter	Symbol	Condition	Min	Typ	Max	Unit
<b>Off Characteristics</b>						
Drain-Source Breakdown Voltage	$\text{BV}_{\text{DSS}}$	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=-250\mu\text{A}$	-100	-	-	V
Zero Gate Voltage Drain Current	$I_{\text{DSS}}$	$V_{\text{DS}}=-100\text{V}, V_{\text{GS}}=0\text{V}$	-	-	1	$\mu\text{A}$
Gate-Body Leakage Current	$I_{\text{GSS}}$	$V_{\text{GS}}=\pm20\text{V}, V_{\text{DS}}=0\text{V}$	-	-	$\pm10$	$\mu\text{A}$
<b>On Characteristics</b> <sup>(Note 3)</sup>						
Gate Threshold Voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{D}}=-250\mu\text{A}$	-1	-1.9	-3	V
Drain-Source On-State Resistance	$R_{\text{DS}(\text{ON})}$	$V_{\text{GS}}=-10\text{V}, I_{\text{D}}=-10\text{A}$	-	170	200	$\text{m}\Omega$
Forward Transconductance	$g_{\text{FS}}$	$V_{\text{DS}}=-5\text{V}, I_{\text{D}}=-10\text{A}$	12	-	-	S
<b>Dynamic Characteristics</b> <sup>(Note 4)</sup>						
Input Capacitance	$C_{\text{iss}}$	$V_{\text{DS}}=-50\text{V}, V_{\text{GS}}=0\text{V}, F=1.0\text{MHz}$	-	1734	-	PF
Output Capacitance	$C_{\text{oss}}$		-	86	-	PF
Reverse Transfer Capacitance	$C_{\text{rss}}$		-	40	-	PF
<b>Switching Characteristics</b> <sup>(Note 4)</sup>						
Turn-on Delay Time	$t_{\text{d}(\text{on})}$	$V_{\text{DD}}=-50\text{V}, I_{\text{D}}=-10\text{A}, V_{\text{GS}}=-10\text{V}, R_{\text{GEN}}=9.1\Omega$	-	12	-	nS
Turn-on Rise Time	$t_r$		-	52	-	nS
Turn-Off Delay Time	$t_{\text{d}(\text{off})}$		-	28	-	nS
Turn-Off Fall Time	$t_f$		-	38	-	nS
Total Gate Charge	$Q_g$	$V_{\text{DS}}=-50\text{V}, I_{\text{D}}=-10\text{A}, V_{\text{GS}}=-10\text{V}$	-	33.1	-	nC
Gate-Source Charge	$Q_{\text{gs}}$		-	4.2	-	nC
Gate-Drain Charge	$Q_{\text{gd}}$		-	7.1	-	nC
<b>Drain-Source Diode Characteristics</b>						
Diode Forward Voltage <sup>(Note 3)</sup>	$V_{\text{SD}}$	$V_{\text{GS}}=0\text{V}, I_{\text{S}}=-10\text{A}$	-	-	-1.2	V
Diode Forward Current <sup>(Note 2)</sup>	$I_{\text{S}}$	-	-	-	-13	A
Reverse Recovery Time	$t_{\text{rr}}$	$T_J = 25^{\circ}\text{C}, IF = -10\text{A}$ $dI/dt = 100\text{A}/\mu\text{s}$ <sup>(Note 3)</sup>	-	35	-	nS
Reverse Recovery Charge	$Q_{\text{rr}}$		-	46	-	nC
Forward Turn-On Time	$t_{\text{on}}$	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)				

**Notes:**

1. Repetitive Rating: Pulse width limited by maximum junction temperature.
2. Surface Mounted on FR4 Board,  $t \leq 10$  sec.
3. Pulse Test: Pulse Width  $\leq 300\mu\text{s}$ , Duty Cycle  $\leq 2\%$ .
4. Guaranteed by design, not subject to production
5. E<sub>AS</sub> condition:  $T_j=25^{\circ}\text{C}, V_{\text{DD}}=-50\text{V}, V_{\text{G}}=-10\text{V}, L=0.5\text{mH}, R_g=25\Omega$

**Test Circuit****1) E<sub>AS</sub> Test Circuit****2) Gate Charge Test Circuit****3) Switch Time Test Circuit**

### Typical Electrical and Thermal Characteristics (Curves)

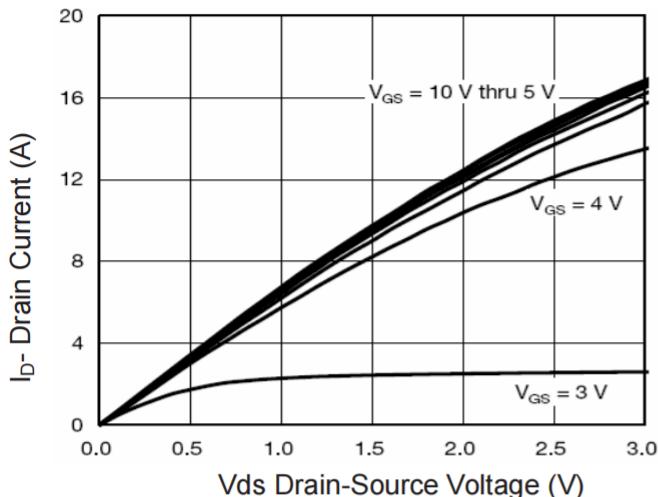


Figure 1 Output Characteristics

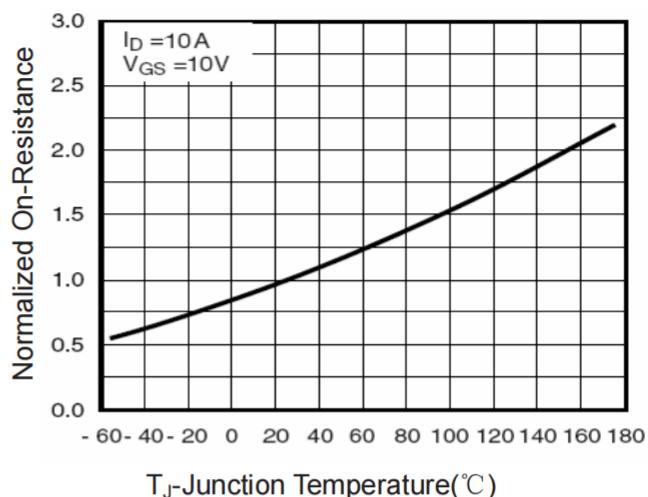


Figure 4 Rdson-JunctionTemperature

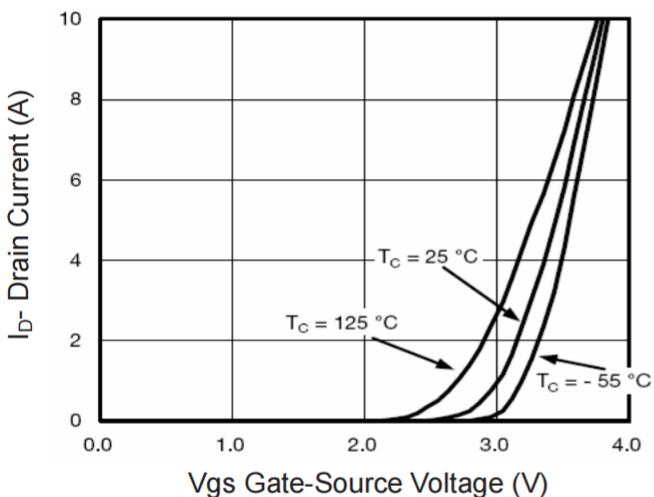


Figure 2 Transfer Characteristics

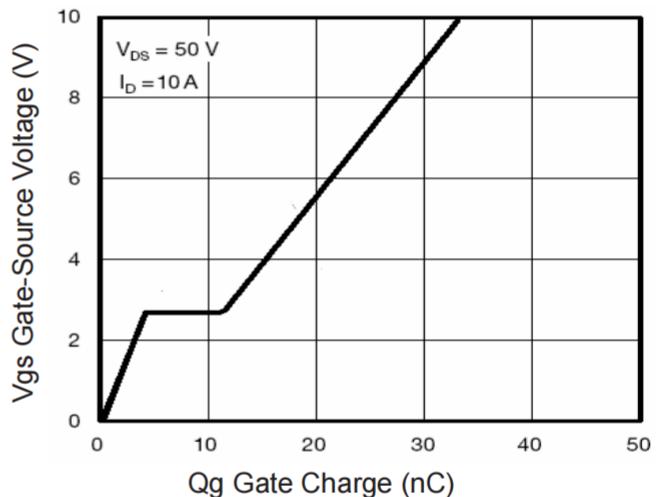


Figure 5 Gate Charge



Figure 3 Rdson- Drain Current

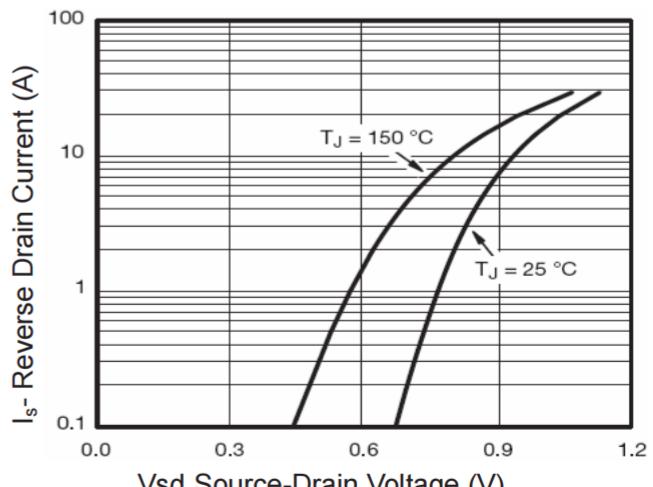


Figure 6 Source- Drain Diode Forward

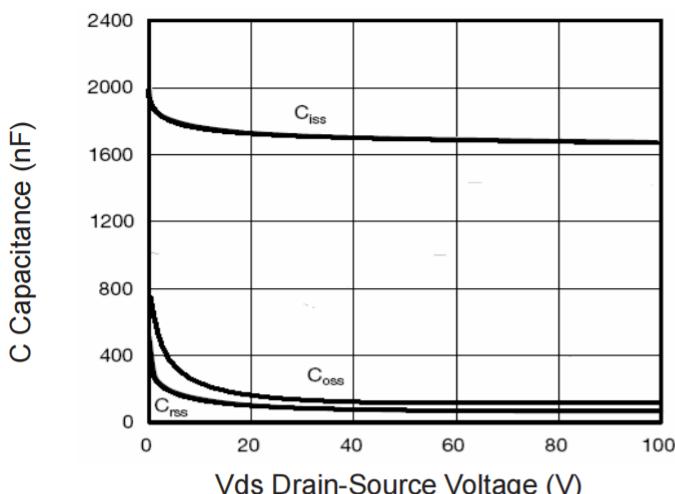


Figure 7 Capacitance vs Vds

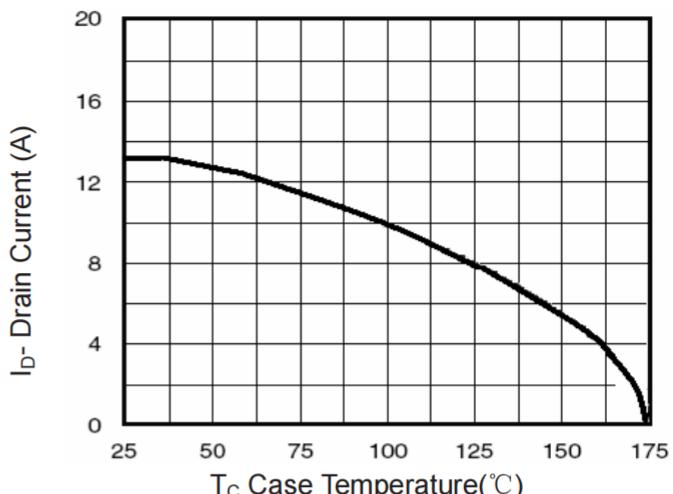


Figure 9 Drain Current vs Case Temperature

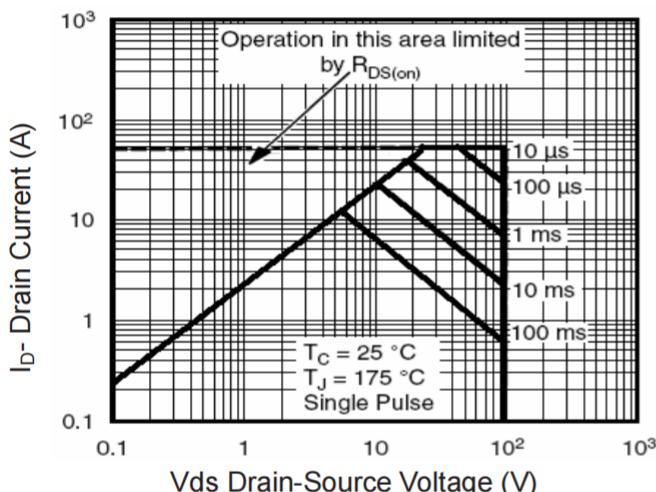


Figure 8 Safe Operation Area

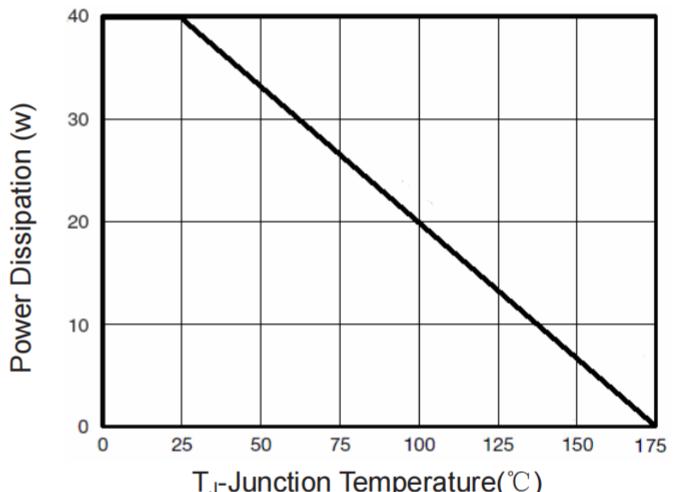


Figure 10 Power De-rating

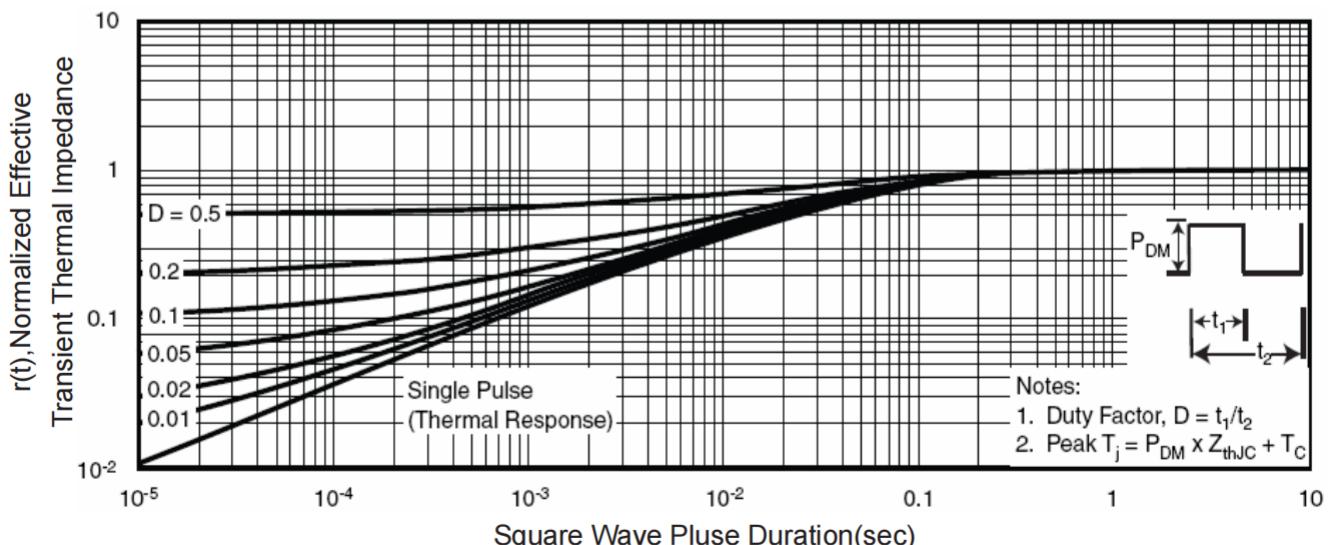


Figure 11 Normalized Maximum Transient Thermal Impedance

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